

BEST AVAILABLE COPY

PATENT NUMBER and  
ISSUE DATE

U.S. UTILITY Patent Application

APPL NUM	FILING DATE	CLASS	SUBCLASS	GAU	EXAMINER
10082648	02/22/2002	438	694	1765	DeD.

\*\*APPLICANTS: Chen Tze-Chiang; Han Liang-Kai;

\*\*CONTINUING DATA VERIFIED:

\*\* FOREIGN APPLICATIONS VERIFIED:

PG-PUB DO NOT PUBLISH ☐

RESCIND ☐

Foreign priority claimed ☐ yes ☐ no

35 USC 119 conditions met ☐ yes ☐ no

Verified and Acknowledged Examiners's initials

ATTORNEY DOCKET NO

FIS920010243US1

TITLE : Deep trench isolation of embedded DRAM for improved latch-up immunity

U.S. DEPT. OF COMM./PAT. & TM.-PTO-436L (Rev. 12-94)

NOTICE OF ALLOWANCE MAILED

CLAIMS ALLOWED

Amount Due

Date Paid

Assistant Examiner

Total Claims

Print Claim for  
O.G.

DRAWING

Sheets Drwg.

Figs. Drwg.

Print Fig.

Primary Examiner

PREPARED FOR ISSUE

Application Examiner

TERMINAL

DISCLAIMER

WARNING: The information disclosed herein may be restricted.  
Unauthorized disclosure may be prohibited by the United States Code Title 35,  
Sections 122, 181 and 368; Possession outside the U.S. Patent & Trademark  
Office is restricted to authorized employees and contractors only.

FILED WITH:

☐ DISK (CRF)

☐ CD-ROM

(Attached in pocket on right inside flap)